

<b>Search Notes</b>		Application/Control No.	Applicant(s)/Patent under Re examination
		10/721,747	HEINRICH ET AL.
		Examiner	Art Unit
		Dinh Q. Nguyen	3752

SEARCHED			
Class	Subclass	Date	Examiner
299	597		
	594		
	434.5		
	423	1-24-05	NN
451	102	1-24-05	NN
118	308	1-24-05	NN
427	192	1-24-05	NN
UPDATED SEARCH		7-25-05	NN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner